Please read this notice before using the TAIYO YUDEN products.

I REMINDERS

Product information in this catalog is as of October 2017. All of the contents specified herein are subject to change without notice due to technical improvements, etc. Therefore, please check for the latest information carefully before practical application or use of our products.

Please note that TAIYO YUDEN shall not be in any way responsible for any damages and defects in products or equipment incorporating our products, which are caused under the conditions other than those specified in this catalog or individual product specification sheets.

- Please contact TAIYO YUDEN for further details of product specifications as the individual product specification sheets are available.
- Please conduct validation and verification of our products in actual condition of mounting and operating environment before using our products.
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Please do not incorporate our products into any equipment requiring high levels of safety and/or reliability (e.g., aerospace equipment, aviation equipment*, medical equipment classified as Class IV by IMDRF, nuclear control equipment, undersea equipment, military equipment).

*Note: There is a possibility that our products can be used only for aviation equipment that does not directly affect the safe operation of aircraft (e.g., in-flight entertainment, cabin light, electric seat, cooking equipment) if such use meets requirements specified separately by TAIYO YUDEN. Please be sure to contact TAIYO YUDEN for further information before using our products for such aviation equipment.

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Caution for Export

Some of our products listed in this catalog may require specific procedures for export according to "U.S. Export Administration Regulations", "Foreign Exchange and Foreign Trade Control Law" of Japan, and other applicable regulations. Should you have any questions on this matter, please contact our sales staff.

MULTILAYER CERAMIC CAPACITORS



PARTS NUMBER

JM	Κ	3 1	6	\triangle	В	J	1	0	6	М	L	—	Т	\triangle
1 2	3	4)	5	(6	5)		7		8	9	(10)	1	(12)

(1)Rated voltage

Trated voltage	
Code	Rated voltage[VDC]
Р	2.5
А	4
J	6.3
L	10
E	16
Т	25
G	35
U	50
Н	100
Q	250
S	630

②Series name	
Code	Series name
М	Multilayer ceramic capacitor
V	Multilayer ceramic capacitor for high frequency
W	LW reverse type multilayer capacitor

③End terminatio	n
Code	End termination
К	Plated
S	Cu Internal Electrodes

 $\Delta =$ Blank space

(4)Dimension(L×W)

Туре	Dimensions (L × W) [mm]	EIA(inch)					
021	0.25 × 0.125	008004					
042	0.4 × 0.2	01005					
063	0.6 × 0.3	0201					
105	1.0 × 0.5	0402					
105	0.52× 1.0 ※	0204					
107	1.6 × 0.8	0603					
107	0.8 × 1.6 💥	0306					
010	2.0 × 1.25	0805					
212	1.25× 2.0 💥	0508					
316	3.2 × 1.6	1206					
325	3.2 × 2.5	1210					
432	4.5 × 3.2	1812					

Note : ※LW reverse type(□WK) only

ode	Туре	L[mm]	W[mm]	T[mm]
7	ALL	Standard	Standard	Standard
	063	0.6 ± 0.05	0.3 ± 0.05	0.3 ± 0.05
	105	1.0±0.10	0.5±0.10	0.5±0.10
	107	1.6+0.15/-0.05	0.8+0.15/-0.05	0.8+0.15/-0.05
				0.45 ± 0.05
A	212	2.0+0.15/-0.05	1.25+0.15/-0.05	0.85±0.10
				1.25+0.15/-0.05
	316	2 2 + 0 20	16+020	0.85±0.10
		3.2 ± 0.20	1.6±0.20	1.6±0.20
	325	3.2 ± 0.30	2.5±0.30	2.5±0.30
	063	0.6±0.09	0.3±0.09	0.3 ± 0.09
	105	1.0+0.15/-0.05	0.5+0.15/-0.05	0.5+0.15/-0.05
	107	1.6+0.20/-0	0.8+0.20/-0	0.45±0.05
В	107	1.8+0.20/-0	0.8+0.20/-0	0.8+0.20/-0
Б				0.45±0.05
	212	2.0+0.20/-0	1.25+0.20/-0	0.85±0.10
-				1.25+0.20/-0
	316	3.2±0.30	1.6±0.30	1.6±0.30
С	105	1.0+0.20/-0	0.5+0.20/-0	0.5 + 0.20 / -0

⁽⁶⁾Temperature characteristics code

I Code all a la administración de consistencia.	(Euclidean Community	I a set all a dia solution in	والمتعادية الطارينية	
High dielectric type	everyoung Super	low distortion	muitilaver c	ceramic capacitor)

Code		cable dard	Temperature range[°C]	Ref. Temp.[°C]	Capacitance change	Capacitance tolerance	Tolerance code										
	JIS	В	$-25 \sim + 85$	20	±10%	±10%	К										
BJ	315	В	$-25 \sim + 85$	20	±10%	±20%	М										
БJ	EIA	X5R	$-55 \sim + 85$	25	±15%	±10%	К										
	EIA	YOK	$-55 \sim + 85$		±15%	±20%	М										
В7	EIA	X7R	$-55 \sim +125$	25	±15%	±10%	К										
ы	D/ EIA	A/N	55° * T 125	25	13,0	±20%	М										
C6			VAC	VAS	VAS	Vec	VAS	Vec		EIA X6S		A X6S	$-55 \sim +105$	25	±22%	±10%	К
0	EIA	702	$-55 \sim \pm 105$	20	±22%	±20%	М										
C7	EIA	X7S	$-55 \sim +125$	25	±22%	±10%	К										
07	EIA	~/3	- 55/~ + 125	20	<u> </u>	±20%	М										
1.5010		EIA X5R -55~+ 85			05	150/	±10%	К									
LD(※)	EIA X5		25	±15%	±20%	М											

Note : & LD Low distortion high value multilayer ceramic capacitor

 Δ = Blank space

This catalog contains the typical specification only due to the limitation of space. When you consider the purchase of our products, please check our product specification sheets. For details of each product (characteristics graph, reliability information, precautions for use, and so on), see our website (http://www.ty-top.com/).

■Temperature compensating type

Code	Code		Temperature	Ref. Temp.[°C]	Capacitance change	Capacitance	Tolerance
Oode	stan	dard	range[°C]		Capacitance change	tolerance	code
						$\pm 0.05 pF$	A
						±0.1pF	В
CG	EIA	C0G	-55~+125	25	0±30ppm/°C	±0.25pF	С
						±0.5pF	D
						±5%	J
	110			5 <u>20</u> 25		±0.25pF	С
UJ	JIS	UJ	$-55 \sim +125$			±0.5pF	D
	EIA	U2J				±5%	J
	JIS	UK	$-55 \sim +125$	20	750-+ 250	+0.0F= F	0
UK	EIA	U2K	$-55 \sim +125$	25	-750 ± 250 ppm/°C	±0.25pF	С
SL	JIS	SL	$-55 \sim +125$	20	+350~-1000ppm/°C	±5%	J

6 Series code

 Super low distortion multilayer ceramic capacitor 				
Code	Series code			
SD	Standard			

•Medium-High Voltage Multilayer Ceramic Capacitor

Code	Series code
SD	Standard

Nominal capacitance

Code (example)	Nominal capacitance
0R5	0.5pF
010	1pF
100	10pF
101	100pF
102	1,000pF
103	10,000pF
104	0.1 <i>µ</i> F
105	1.0 <i>µ</i> F
106	10 µ F
107	100 µ F

Note : R=Decimal point

$\textcircled{\textbf{8}} \textbf{Capacitance tolerance}$

Code	Capacitance tolerance
А	±0.05pF
В	±0.1pF
С	±0.25pF
D	±0.5pF
F	±1pF
G	±2%
J	$\pm 5\%$
К	±10%
М	±20%
Z	+80/-20%

9Thickness	
Code	Thickness[mm]
К	0.125
Н	0.13
E	0.18
С	0.0
D	0.2
Р	0.2
Т	0.3
К	0.45(107type or more)
V	
W	0.5
A	0.8
D	0.85(212type or more)
F	1.15
G	1.25
L	1.6
N	1.9
Y	2.0 max
М	2.5

①Special code

0-1	
Code	Special code
—	Standard

①Packaging	
Code	Packaging
F	ϕ 178mm Taping (2mm pitch)
Т	ϕ 178mm Taping (4mm pitch)
Р	ϕ 178mm Taping (4mm pitch, 1000 pcs/reel)
P	325 type(Thickness code M)
R	ϕ 178mm Taping (2mm pitch)105type only
R	(Thickness code E,H)
W	<i>ф</i> 178mm Taping(1mm pitch)021/042type only
12Internal code	

2		
	Code	Internal code
	Δ	Standard



L
W
e t

T

Type(EIA)		D	imension [mm]		
Type(EIA)	L	W	Т	*1	е
□MK021(008004)	0.25±0.013	0.125±0.013	0.125±0.013	Κ	0.0675±0.0275
□VS021(008004)	0.25 ± 0.013	0.125 ± 0.013	0.125 ± 0.013	К	0.0675 ± 0.0275
□MK042(01005)	0.4±0.02	0.2±0.02	0.2±0.02	C D	0.1±0.03
□VS042(01005)	0.4±0.02	0.2±0.02	0.2 ± 0.02	С	0.1±0.03
□MK063(0201)	0.6±0.03	0.3±0.03	0.3±0.03	P T	0.15±0.05
			0.13±0.02	Н	
			0.18±0.02	Е	
□MK105(0402)	1.0 ± 0.05	0.5 ± 0.05	0.2±0.02	С	0.25 ± 0.10
			0.3±0.03	Р	
			0.5 ± 0.05	V	
□VK105(0402)	1.0 ± 0.05	0.5 ± 0.05	0.5 ± 0.05	W	0.25±0.10
□WK105(0204)※	0.52 ± 0.05	1.0 ± 0.05	0.3 ± 0.05	Р	0.18±0.08
□MK107(0603)	1.6±0.10	0.8±0.10	0.45 ± 0.05	Κ	0.35 ± 0.25
	1.0±0.10	0.8±0.10	0.8±0.10	Α	0.35±0.25
□WK107(0306)※	0.8±0.10	1.6±0.10	0.5 ± 0.05	V	0.25 ± 0.15
			0.45 ± 0.05	К	
□MK212(0805)	2.0 ± 0.10	1.25 ± 0.10	0.85 ± 0.10	D	0.5 ± 0.25
			1.25 ± 0.10	G	
□WK212(0508)※	1.25 ± 0.15	2.0±0.15	0.85 ± 0.10	D	0.3±0.2
			0.85 ± 0.10	D	
□MK316(1206)	3.2 ± 0.15	1.6 ± 0.15	1.15 ± 0.10	F	0.5+0.35/-0.25
			1.6±0.20	L	
			0.85 ± 0.10	D	
			1.15±0.10	F	
□MK325(1210)	3.2 ± 0.30	2.5 ± 0.20	1.9±0.20	Ν	0.6 ± 0.3
			1.9+0.1/-0.2	Y	
			2.5±0.20	М	
□MK432(1812)	4.5 ± 0.40	3.2 ± 0.30	2.5 ± 0.20	М	0.9 ± 0.6

※ LW reverse type

Note : X. LW reverse type, *1.Thickness code

STANDARD QUANTITY

Turne	EIA (inch)		nension	Standard q	uantity[pcs]		
Туре	EIA (Incn)	[mm]	Code	Paper tape	Embossed tape		
021	008004	0.125	К	-	50000		
042	01005	0.2	С	_	40000		
042	01005	0.2	D	_	40000		
063	0201	0.3	Р	15000	_		
003	0201	0.5	Т	13000			
		0.13	Н	—	20000		
		0.18	E	—	15000		
	0402	0.2	С	20000	-		
105	0402	0.3	Р	15000	_		
		0.5	V				
		0.5	W	10000	-		
	0204 💥	0.30	Р		50000 40000 20000 15000 		
	0603	0.45	К	4000	_		
107		0.8	А	4000			
	0306 💥	0.50	V	-	4000		
		0.45	К	4000	_		
212	0805	0.85	D	4000			
212		1.25	G	-	3000		
	0508 💥	0.85	D	4000	—		
		0.85	D	4000	-		
316	1206	1.15	F	—	3000		
		1.6	L	-	2000		
		0.85	D				
		1.15	F		2000		
325	1210	1.9	N		2000		
		2.0 max	Y				
		2.5	М	-	1000		
432	1812	2.5	М	-	500		

Medium-High Voltage Multilayer Ceramic Capacitors

105TYPE

[Temperature Characteristic B7 : X7R] 0.5mm thickness(V)

Part number 1	Part number 2	Rated voltage [V]	Tempe charact		Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK105 B7221[]V-F				X7R	220 p	±10, ±20	2.5	200	0.5 ± 0.05	R
HMK105 B7331[]V-F				X7R	330 p	±10, ±20	2.5	200	0.5 ± 0.05	R
HMK105 B7471[]V-F				X7R	470 p	±10, ±20	2.5	200	0.5 ± 0.05	R
HMK105 B7681[]V-F				X7R	680 p	±10, ±20	2.5	200	0.5 ± 0.05	R
HMK105 B7102[]V-F		100		X7R	1000 p	±10, ±20	2.5	200	0.5 ± 0.05	R
HMK105 B7152[]V-F				X7R	1500 p	±10, ±20	2.5	200	0.5 ± 0.05	R
HMK105 B7222[]V-F				X7R	2200 p	±10, ±20	2.5	200	0.5 ± 0.05	R
HMK105 B7332[]V-F				X7R	3300 p	±10, ±20	2.5	200	0.5 ± 0.05	R
HMK105 B7472[]V-F				X7R	4700 p	±10, ±20	2.5	200	0.5 ± 0.05	R

[Temperature Characteristic CG : CG/C0G] 0.5mm thickness(V)

Part number 1	Part number 2	Rated voltage [V]	Tempe charact	erature eristics	Capacitance [F]	Capacitance tolerance	Q (at 1MHz) min	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK105 CG080DV-F			CG	COG	8 p	±0.5pF	560	200	0.5 ± 0.05	R
HMK105 CG090DV-F			CG	C0G	9 p	±0.5pF	580	200	0.5 ± 0.05	R
HMK105 CG100DV-F			CG	COG	10 p	±0.5pF	600	200	0.5 ± 0.05	R
HMK105 CG120JV-F			CG	C0G	12 p	±5%	640	200	0.5 ± 0.05	R
HMK105 CG150JV-F			CG	C0G	15 p	±5%	700	200	0.5 ± 0.05	R
HMK105 CG180JV-F			CG	C0G	18 p	±5%	760	200	0.5 ± 0.05	R
HMK105 CG220JV-F			CG	COG	22 p	±5%	840	200	0.5 ± 0.05	R
HMK105 CG240JV-F		100	CG	COG	24 p	±5%	880	200	0.5 ± 0.05	R
HMK105 CG270JV-F		100	CG	COG	27 p	±5%	940	200	0.5 ± 0.05	R
HMK105 CG330JV-F			CG	COG	33 p	±5%	1000	200	0.5 ± 0.05	R
HMK105 CG390JV-F			CG	COG	39 p	±5%	1000	200	0.5 ± 0.05	R
HMK105 CG470JV-F			CG	COG	47 p	±5%	1000	200	0.5 ± 0.05	R
HMK105 CG560JV-F			CG	COG	56 p	±5%	1000	200	0.5 ± 0.05	R
HMK105 CG680JV-F		Γ	CG	C0G	68 p	±5%	1000	200	0.5 ± 0.05	R
HMK105 CG820JV-F			CG	C0G	82 p	±5%	1000	200	0.5 ± 0.05	R
HMK105 CG101JV-F			CG	C0G	100 p	±5%	1000	200	0.5 ± 0.05	R

107TYPE

[Temperature Characteristic BJ : B/X5R] 0.8mm thickness(A)

Part number 1	Part number 2	Rated voltage [V]	Tempe charact	erature eristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK107 BJ102[]A-T			В	X5R ^{*1}	1000 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 BJ152[]A-T			В	X5R ^{*1}	1500 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 BJ222[]A-T			В	X5R ^{*1}	2200 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 BJ332[]A-T			В	X5R ^{*1}	3300 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 BJ472[]A-T			В	X5R ^{*1}	4700 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 BJ682[]A-T			В	X5R ^{*1}	6800 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 BJ103[]A-T		100	В	X5R ^{*1}	0.01 μ	±10, ±20	3.5	200	0.8±0.10	R
HMK107 BJ153[]A-T			В	X5R ^{*1}	0.015 μ	±10, ±20	3.5	200	0.8±0.10	R
HMK107 BJ223[]A-T			В	X5R*1	0.022 μ	±10, ±20	3.5	200	0.8±0.10	R
HMK107 BJ333[]A-T			В	X5R*1	0.033 μ	±10, ±20	3.5	200	0.8±0.10	R
HMK107 BJ473[]A-T		-	В	X5R ^{*1}	0.047 μ	±10, ±20	3.5	200	0.8±0.10	R
HMK107 BJ104[]A-T			В	X5R ^{*1}	0.1 μ	±10, ±20	3.5	200	0.8±0.10	R
HMK107 BJ224[]A-TE			В	X5R ^{*1}	0.22 µ	±10, ±20	3.5	150	0.8±0.10	R

[Temperature Characteristic C7 : X7S] 0.8mm thickness(A)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics		Capacitance [F]	Capacitance tolerance [%]	tanδ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK107 C7224[]A-TE		100		X7S	0.22 μ	±10, ±20	3.5	150	0.8±0.10	R

[Temperature Characteristic B7 : X7R] 0.8mm thickness(A)

Part number 1	Part number 2	Rated voltage [V]	Tempe charact	erature eristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK107 B7102[]A-T				X7R	1000 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7152[]A-T				X7R	1500 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7222[]A-T				X7R	2200 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7332[]A-T				X7R	3300 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7472[]A-T				X7R	4700 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7682[]A-T		100		X7R	6800 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7103[]A-T		100		X7R	0.01 µ	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7153[]A-T				X7R	0.015 μ	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7223[]A-T				X7R	0.022 μ	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7333[]A-T				X7R	0.033 μ	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7473[]A-T				X7R	0.047 μ	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7104[]A-T				X7R	0.1 μ	±10, ±20	3.5	200	0.8±0.10	R

[Temperature Characteristic SD : Standard] 0.8mm thickness(A)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK107 SD101KA-T				100 p	±10	0.1	200	0.8±0.10	R
HMK107 SD121KA-T				120 p	±10	0.1	200	0.8±0.10	R
HMK107 SD151KA-T				150 p	±10	0.1	200	0.8±0.10	R
HMK107 SD181KA-T				180 p	±10	0.1	200	0.8±0.10	R
HMK107 SD221KA-T				220 p	±10	0.1	200	0.8±0.10	R
HMK107 SD271KA-T				270 p	±10	0.1	200	0.8±0.10	R
HMK107 SD331KA-T		100	Standard Type	330 p	±10	0.1	200	0.8±0.10	R
HMK107 SD391KA-T				390 p	±10	0.1	200	0.8±0.10	R
HMK107 SD471KA-T				470 p	±10	0.1	200	0.8±0.10	R
HMK107 SD561KA-T				560 p	±10	0.1	200	0.8±0.10	R
HMK107 SD681KA-T				680 p	±10	0.1	200	0.8±0.10	R
HMK107 SD821KA-T			Ī	820 p	±10	0.1	200	0.8±0.10	R
HMK107 SD102KA-T				1000 p	±10	0.1	200	0.8±0.10	R

e212TYPE

【Temperature Characteristic BJ : B/X5R】 1.25mm thickness(G)

Part number 1	Part number 2	Rated voltage [V]	•	erature eristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK212 BJ103[]G-T			В	X5R ^{*1}	0.01 µ	±10, ±20	3.5	200	1.25 ± 0.10	R
HMK212 BJ153[]G-T			В	X5R*1	0.015 μ	±10, ±20	3.5	200	1.25 ± 0.10	R
HMK212 BJ223[]G-T			В	X5R ^{*1}	0.022 μ	±10, ±20	3.5	200	1.25 ± 0.10	R
HMK212 BJ333]]G-T			В	X5R ^{*1}	0.033 μ	±10, ±20	3.5	200	1.25 ± 0.10	R
HMK212 BJ473[]G-T		100	В	X5R ^{*1}	0.047 μ	±10, ±20	3.5	200	1.25 ± 0.10	R
HMK212 BJ683[]G-T		100	В	X5R ^{*1}	0.068 μ	±10, ±20	3.5	200	1.25 ± 0.10	R
HMK212 BJ104[]G-T			В	X5R ^{*1}	0.1 μ	±10, ±20	3.5	200	1.25 ± 0.10	R
HMK212 BJ224[]G-T			В	X5R ^{*1}	0.22 μ	±10, ±20	3.5	200	1.25 ± 0.10	R
HMK212 BJ474[]G-TE			В	X5R ^{*1}	0.47 μ	±10, ±20	3.5	150	1.25 ± 0.10	R
HMK212BBJ105[]G-TE			В	X5R*1	1μ	±10, ±20	3.5	150	1.25+0.20/-0	R
QMK212 BJ472[]G-T			В	X5R*1	4700 p	±10, ±20	2.5	150	1.25 ± 0.10	R
QMK212 BJ682[]G-T			В	X5R ^{*1}	6800 p	±10, ±20	2.5	150	1.25 ± 0.10	R
QMK212 BJ103[]G-T		250	В	X5R ^{*1}	0.01 µ	±10, ±20	2.5	150	1.25 ± 0.10	R
QMK212 BJ153[]G-T] [В	X5R ^{*1}	0.015 μ	±10, ±20	2.5	150	1.25 ± 0.10	R
QMK212 BJ223[]G-T			В	X5R ^{*1}	0.022 μ	±10, ±20	2.5	150	1.25 ± 0.10	R

[Temperature Characteristic BJ : B/X5R] 0.85mm thickness(D)

	Part number 1	Part number 2	Rated voltage [V]		erature eristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
(QMK212 BJ102[]D-T			В	X5R ^{*1}	1000 p	±10, ±20	2.5	150	0.85±0.10	R
(QMK212 BJ152[]D-T		250	В	X5R*1	1500 p	±10, ±20	2.5	150	0.85±0.10	R
(QMK212 BJ222[]D-T		250	В	X5R*1	2200 p	±10, ±20	2.5	150	0.85±0.10	R
(QMK212 BJ332[]D-T			В	X5R ^{*1}	3300 p	±10, ±20	2.5	150	0.85±0.10	R

[Temperature Characteristic C7 : X7S] 1.25mm thickness(G)

Part number 1	Part number 2	Rated voltage [V]	Tempe charact		Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK212 C7474[]G-TE		100		X7S	0.47 μ	±10, ±20	3.5	150	1.25 ± 0.10	R
HMK212BC7105[]G-TE		100		X7S	1μ	±10, ±20	3.5	150	1.25+0.20/-0	R

【Temperature Characteristic B7 : X7R】 1.25mm thickness(G)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK212 B7103[]G-T			X7R	0.01 µ	±10, ±20	3.5	200	1.25 ± 0.10	R
HMK212 B7153[]G-T			X7R	0.015 µ	±10, ±20	3.5	200	1.25 ± 0.10	R
HMK212 B7223[]G-T			X7R	0.022 µ	±10, ±20	3.5	200	1.25 ± 0.10	R
HMK212 B7333[]G-T		100	X7R	0.033 µ	±10, ±20	3.5	200	1.25 ± 0.10	R
HMK212 B7473[]G-T		100	X7R	0.047 μ	±10, ±20	3.5	200	1.25 ± 0.10	R
HMK212 B7683[]G-T			X7R	0.068 µ	±10, ±20	3.5	200	1.25 ± 0.10	R
HMK212 B7104[]G-T			X7R	0.1 μ	±10, ±20	3.5	200	1.25±0.10	R
HMK212 B7224[]G-T			X7R	0.22 μ	±10, ±20	3.5	200	1.25±0.10	R
QMK212 B7472[]G-T			X7R	4700 p	±10, ±20	2.5	150	1.25 ± 0.10	R
QMK212 B7682[]G-T			X7R	6800 p	±10, ±20	2.5	150	1.25 ± 0.10	R
QMK212 B7103[]G-T		250	X7R	0.01 µ	±10, ±20	2.5	150	1.25 ± 0.10	R
QMK212 B7153[]G-T]	X7R	0.015 μ	±10, ±20	2.5	150	1.25 ± 0.10	R
QMK212 B7223[]G-T			X7R	0.022 μ	±10, ±20	2.5	150	1.25 ± 0.10	R

[Temperature Characteristic B7 : X7R] 0.85mm thickness(D)

Part number 1	Part number 2	Rated voltage [V]	Temperat characteri		Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
QMK212 B7102[]D-T				X7R	1000 p	±10, ±20	2.5	150	0.85±0.10	R
QMK212 B7152[]D-T		250		X7R	1500 p	±10, ±20	2.5	150	0.85±0.10	R
QMK212 B7222[]D-T		250		X7R	2200 p	±10, ±20	2.5	150	0.85±0.10	R
QMK212 B7332[]D-T				X7R	3300 p	±10, ±20	2.5	150	0.85±0.10	R

[Temperature Characteristic SD : Standard] 0.85mm thickness(D)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK212 SD222KD-T		100		2200 p	±10	0.1	200	0.85±0.10	R
HMK212 SD472KD-T		100		4700 p	±10	0.1	200	0.85±0.10	R
QMK212 SD101KD-T				100 p	±10	0.1	150	0.85±0.10	R
QMK212 SD121KD-T				120 p	±10	0.1	150	0.85±0.10	R
QMK212 SD151KD-T				150 p	±10	0.1	150	0.85±0.10	R
QMK212 SD181KD-T				180 p	±10	0.1	150	0.85±0.10	R
QMK212 SD221KD-T			Charlend Tar	220 p	±10	0.1	150	0.85±0.10	R
QMK212 SD331KD-T		250	Standard Type	330 p	±10	0.1	150	0.85 ± 0.10	R
QMK212 SD391KD-T		250		390 p	±10	0.1	150	0.85 ± 0.10	R
QMK212 SD471KD-T				470 p	±10	0.1	150	0.85±0.10	R
QMK212 SD561KD-T				560 p	±10	0.1	150	0.85±0.10	R
QMK212 SD681KD-T				680 p	±10	0.1	150	0.85±0.10	R
QMK212 SD821KD-T				820 p	±10	0.1	150	0.85±0.10	R
QMK212 SD102KD-T				1000 p	±10	0.1	150	0.85±0.10	R

[Temperature Characteristic SD : Standard] 1.25mm thickness(G)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK212 SD392KG-T		100	Standard Type	3900 p	±10	0.1	200	1.25±0.10	R

316TYPE

[Temperature Characteristic BJ : B/X5R] 1.6mm thickness(L)

Part number 1	Part number 2	Rated voltage [V]	Tempe charact	erature eristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK316 BJ473[]L-T			В	X5R ^{*1}	0.047 μ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 BJ683[]L-T			В	X5R ^{*1}	0.068 µ	±10, ±20	3.5	200	1.6 ± 0.20	R
HMK316 BJ104[]L-T			В	X5R*1	0.1 μ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 BJ154[]L-T			В	X5R ^{*1}	0.15 μ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 BJ224[]L-T		100	В	X5R ^{*1}	0.22 μ	±10, ±20	3.5	200	1.6 ± 0.20	R
HMK316 BJ334[]L-T			В	X5R ^{*1}	0.33 µ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 BJ474[]L-T			В	X5R ^{*1}	0.47 μ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 BJ105[]L-T			В	X5R ^{*1}	1μ	±10, ±20	3.5	200	1.6±0.20	R
HMK316ABJ225[]L-TE			В	X5R ^{*1}	2.2 μ	±10, ±20	3.5	150	1.6±0.20	R
QMK316 BJ333[]L-T			В	X5R ^{*1}	0.033 µ	±10, ±20	2.5	150	1.6±0.20	R
QMK316 BJ473[]L-T		250	В	X5R ^{*1}	0.047 μ	±10, ±20	2.5	150	1.6±0.20	R
QMK316 BJ683[L-T		230	В	X5R ^{*1}	0.068 µ	±10, ±20	2.5	150	1.6 ± 0.20	R
QMK316 BJ104[]L-T			В	X5R*1	0.1 μ	±10, ±20	2.5	150	1.6 ± 0.20	R
SMK316 BJ153[]L-T		630	В	X5R ^{*1}	0.015 μ	±10, ±20	2.5	120	1.6±0.20	R
SMK316 BJ223[]L-T		030	В	X5R ^{*1}	0.022 μ	±10, ±20	2.5	120	1.6±0.20	R

[Temperature Characteristic BJ : B/X5R] 1.15mm thickness(F)

Part number 1	Part number 2	Rated voltage [V]		erature teristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
SMK316 BJ102[]F-T			В	X5R ^{*1}	1000 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 BJ152[]F-T			В	X5R ^{*1}	1500 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 BJ222[]F-T			В	X5R ^{*1}	2200 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 BJ332[]F-T		630	В	X5R ^{*1}	3300 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 BJ472[]F-T			В	X5R ^{*1}	4700 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 BJ682[]F-T			В	X5R*1	6800 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 BJ103[F-T			В	X5R*1	0.01 µ	±10, ±20	2.5	120	1.15±0.10	R

[Temperature Characteristic C7 : X7S] 1.6mm thickness(L)

Part number 1	Part number 2	Rated voltage [V]	Tempe characte		Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK316AC7225[L-TE		100		X7S	2.2 μ	±10, ±20	3.5	150	1.6±0.20	R

[Temperature Characteristic B7 : X7R] 1.6mm thickness(L)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK316 B7473[]L-T			X7R	0.047 μ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 B7683[]L-T			X7R	0.068 µ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 B7104[]L-T			X7R	0.1 μ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 B7154[]L-T		100	X7R	0.15 μ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 B7224[]L-T		100	X7R	0.22 µ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 B7334[]L-T			X7R	0.33 µ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 B7474[]L-T			X7R	0.47 μ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 B7105[]L-T			X7R	1μ	±10, ±20	3.5	200	1.6±0.20	R
QMK316 B7333]L-T			X7R	0.033 µ	±10, ±20	2.5	150	1.6±0.20	R
QMK316 B7473[L-T		250	X7R	0.047 μ	±10, ±20	2.5	150	1.6±0.20	R
QMK316 B7683[]L-T		250	X7R	0.068 µ	±10, ±20	2.5	150	1.6±0.20	R
QMK316 B7104[]L-T			X7R	0.1 μ	±10, ±20	2.5	150	1.6±0.20	R
SMK316 B7153[]L-T			X7R	0.015 μ	±10, ±20	2.5	120	1.6±0.20	R
SMK316 B7223[]L-T		630	X7R	0.022 µ	±10, ±20	2.5	120	1.6±0.20	R
SMK316AB7333[]L-T		030	X7R	0.033 µ	±10, ±20	2.5	120	1.6±0.20	R
SMK316AB7473[]L-T			X7R	0.047 μ	±10, ±20	2.5	120	1.6±0.20	R

PARTS NUMBER

[Temperature Characteristic B7 : X7R] 1.15mm thickness(F)

		Rated voltage	Tempera	ature	Capacitance	Capacitance tolerance	tan δ	HTLT	*3 = 7	Soldering
Part number 1	Part number 2	[V]	characte	eristics	[F]	[%]	[%]	Rated voltage x %	Thickness ^{*3} [mm]	R:Reflow W:Wave
SMK316 B7102[]F-T				X7R	1000 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 B7152[]F-T				X7R	1500 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 B7222[]F-T				X7R	2200 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 B7332[]F-T		630		X7R	3300 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 B7472[]F-T				X7R	4700 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 B7682[]F-T				X7R	6800 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 B7103[]F-T				X7R	0.01 µ	±10, ±20	2.5	120	1.15±0.10	R

【Temperature Characteristic SD : Standard 】 1.6mm thickness(L)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK316 SD223KL-T		100	Standard Type	0.022 µ	±10	0.1	200	1.6±0.20	R
QMK316 SD103KL-T		250	Standard Type	0.01 µ	±10	0.1	150	1.6±0.20	R

325TYPE

【Temperature Characteristic BJ : B/X5R】 2.5mm thickness(M)

Part number 1	Part number 2	Rated voltage [V]	Tempe charact	erature eristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK325 BJ225[]M-P		100	В	X5R ^{*1}	2.2 μ	±10, ±20	3.5	200	2.5±0.20	R
HMK325 BJ475[]M-PE		100	В	X5R ^{*1}	4.7 μ	±10, ±20	3.5	150	2.5±0.20	R

[Temperature Characteristic BJ : B/X5R] 1.9mm thickness(N)

Part number 1	Part number 2	Rated voltage [V]		erature eristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK325 BJ154[]N-T			В	X5R ^{*1}	0.15 μ	±10, ±20	3.5	200	1.9±0.20	R
HMK325 BJ224[]N−T			В	X5R ^{*1}	0.22 μ	±10, ±20	3.5	200	1.9±0.20	R
HMK325 BJ334[]N−T			В	X5R ^{*1}	0.33 μ	±10, ±20	3.5	200	1.9±0.20	R
HMK325 BJ474[]N-T		100	В	X5R ^{*1}	0.47 μ	±10, ±20	3.5	200	1.9±0.20	R
HMK325 BJ684[]N−T			В	X5R*1	0.68 µ	±10, ±20	3.5	200	1.9±0.20	R
HMK325 BJ105∏N-T			В	X5R*1	1μ	±10, ±20	3.5	200	1.9±0.20	R
HMK325 BJ475[]N-TE			В	X5R ^{*1}	4.7 μ	±10, ±20	3.5	150	1.9±0.20	R
QMK325 BJ473[]N-T			В	X5R ^{*1}	0.047 μ	±10, ±20	2.5	150	1.9±0.20	R
QMK325 BJ104[]N-T		250	В	X5R ^{*1}	0.1 μ	±10, ±20	2.5	150	1.9±0.20	R
QMK325 BJ154[]N-T		230	В	X5R ^{*1}	0.15 μ	±10, ±20	2.5	150	1.9±0.20	R
QMK325 BJ224[]N-T			В	X5R ^{*1}	0.22 μ	±10, ±20	2.5	150	1.9±0.20	R
SMK325 BJ223[]N-T			В	X5R ^{*1}	0.022 μ	±10, ±20	2.5	120	1.9±0.20	R
SMK325 BJ333[]N-T		630	В	X5R ^{*1}	0.033 μ	±10, ±20	2.5	120	1.9 ± 0.20	R
SMK325 BJ473[]N-T			В	X5R ^{*1}	0.047 μ	±10, ±20	2.5	120	1.9±0.20	R

[Temperature Characteristic BJ : B/X5R] 1.15mm thickness(F)

Part number 1	Part number 2	Rated voltage [V]		erature teristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK325 BJ104[]F-T		100	В	X5R ^{*1}	0.1 μ	±10, ±20	3.5	200	1.15±0.10	R

【Temperature Characteristic B7 : X7R】 2.5mm thickness(M)

Part number 1	Part number 2	Rated voltage [V]	Tempe charact		Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave	
HMK325 B7225[]M-P		100		X7R	2.2 μ	±10, ±20	3.5	200	2.5 ± 0.20	R	

[Temperature Characteristic B7 : X7R] 1.9mm thickness(N)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK325 B7154[]N-T			X7R	0.15 μ	±10, ±20	3.5	200	1.9±0.20	R
HMK325 B7224[]N-T			X7R	0.22 μ	±10, ±20	3.5	200	1.9±0.20	R
HMK325 B7334[]N-T		100	X7R	0.33 μ	±10, ±20	3.5	200	1.9±0.20	R
HMK325 B7474[]N-T		100	X7R	0.47 μ	±10, ±20	3.5	200	1.9±0.20	R
HMK325 B7684[]N-T			X7R	0.68 µ	±10, ±20	3.5	200	1.9±0.20	R
HMK325 B7105[]N-T			X7R	1μ	±10, ±20	3.5	200	1.9±0.20	R
QMK325 B7473[]N-T			X7R	0.047 μ	±10, ±20	2.5	150	1.9±0.20	R
QMK325 B7104[]N-T		250	X7R	0.1 μ	±10, ±20	2.5	150	1.9±0.20	R
QMK325 B7154[]N-T		230	X7R	0.15 μ	±10, ±20	2.5	150	1.9±0.20	R
QMK325 B7224[]N-T			X7R	0.22 μ	±10, ±20	2.5	150	1.9±0.20	R
SMK325 B7223[]N-T			X7R	0.022 μ	±10, ±20	2.5	120	1.9±0.20	R
SMK325 B7333[]N-T		630	X7R	0.033 µ	±10, ±20	2.5	120	1.9±0.20	R
SMK325 B7473[]N-T			X7R	0.047 μ	±10, ±20	2.5	120	1.9 ± 0.20	R

[Temperature Characteristic C7 : X7S] 2.5mm thickness(M)

	Part number 1	Part number 2	Rated voltage [V]	Tempe characte		Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
Н	IMK325 C7475[]M-PE		100		X7S	4.7 μ	±10, ±20	3.5	150	2.5±0.20	R

[Temperature Characteristic C7 : X7S] 1.9mm thickness(N)

Part number 1	Part number 2	Rated voltage [V]	Tempe charact	erature eristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK325 C7475[]N-TE		100		X7S	4.7 μ	±10, ±20	3.5	150	1.9 ± 0.20	R

[Temperature Charac	teristic B7 : X7R】	1.15mm thic	kness(F)						
Deutermehren 1	Part number 2	Rated voltage	Temperature	Capacitance	Capacitance tolerance	tan δ	HTLT	*3 r	Soldering R:Reflow
Part number 1	Part number 2	[V]	characteristics	[F]	[%]	[%]	Rated voltage x %	Thickness ^{*°} [mm]	W:Wave
HMK325 B7104□F-T		100	X7R	0.1 <i>u</i>	$\pm 10. \pm 20$	3.5	200	1.15 ± 0.10	R

432TYPE

[Temperature Characteristic BJ : B/X5R] 2.5mm thickness(M)

Part number 1	Part number 2	Rated voltage [V]		erature teristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK432 BJ474[]M-T			В	X5R*1	0.47 μ	±10, ±20	3.5	200	2.5±0.20	R
HMK432 BJ105[]M-T		100	В	X5R ^{*1}	1μ	±10, ±20	3.5	200	2.5 ± 0.20	R
HMK432 BJ155[]M-T		100	В	X5R ^{*1}	1.5 μ	±10, ±20	3.5	200	2.5 ± 0.20	R
HMK432 BJ225[]M-T			В	X5R*1	2.2 μ	±10, ±20	3.5	200	2.5±0.20	R
QMK432 BJ104[]M-T			В	X5R*1	0.1 μ	±10, ±20	2.5	150	2.5±0.20	R
QMK432 BJ224[]M-T		250	В	X5R*1	0.22 μ	±10, ±20	2.5	150	2.5±0.20	R
QMK432 BJ334[]M-T		250	В	X5R*1	0.33 μ	±10, ±20	2.5	150	2.5±0.20	R
QMK432 BJ474[]M-T			В	X5R*1	0.47 μ	±10, ±20	2.5	150	2.5±0.20	R
SMK432 BJ473[]M-T			В	X5R*1	0.047 μ	±10, ±20	2.5	120	2.5±0.20	R
SMK432 BJ683[]M-T		630	В	X5R*1	0.068 µ	±10, ±20	2.5	120	2.5±0.20	R
SMK432 BJ104[]M-T			В	X5R ^{*1}	0.1 μ	±10, ±20	2.5	120	2.5 ± 0.20	R

[Temperature Characteristic B7 : X7R] 2.5mm thickness(M)

Part number 1	Part number 2	Rated voltage [V]	Temper characte		Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HTLT Rated voltage x %	Thickness ^{*3} [mm]	Soldering R:Reflow W:Wave
HMK432 B7474[]M-T				X7R	0.47 μ	±10, ±20	3.5	200	2.5±0.20	R
HMK432 B7105[]M-T		100		X7R	1μ	±10, ±20	3.5	200	2.5 ± 0.20	R
HMK432 B7155[]M-T		100		X7R	1.5 μ	±10, ±20	3.5	200	2.5 ± 0.20	R
HMK432 B7225[]M-T				X7R	2.2 μ	±10, ±20	3.5	200	2.5 ± 0.20	R
QMK432 B7104[]M-T				X7R	0.1 μ	±10, ±20	2.5	150	2.5 ± 0.20	R
QMK432 B7224[]M-T		250		X7R	0.22 μ	±10, ±20	2.5	150	2.5 ± 0.20	R
QMK432 B7334[]M-T		250		X7R	0.33 μ	±10, ±20	2.5	150	2.5±0.20	R
QMK432 B7474[]M-T				X7R	0.47 μ	±10, ±20	2.5	150	2.5±0.20	R
SMK432 B7473[]M-T				X7R	0.047 μ	±10, ±20	2.5	120	2.5±0.20	R
SMK432 B7683[]M-T		630		X7R	0.068 µ	±10, ±20	2.5	120	2.5 ± 0.20	R
SMK432 B7104[]M-T]		X7R	0.1 μ	±10, ±20	2.5	120	2.5 ± 0.20	R

Multilayer Ceramic Capacitors

PACKAGING

①Minimum Quantity

_ ()	Thick	ness	Standard o	uantity [pcs]
Type(EIA)	mm	code	Paper tape	Embossed tape
□MK021(008004)	0.105	к		50000
□VS021(008004)	0.125	n	_	50000
MK042(01005)	0.2	C, D		40000
□VS042(01005)	0.2	С		40000
□MK063(0201)	0.3	P,T	15000	_
□WK105(0204) 💥	0.3	Р	10000	_
	0.13	Н	_	20000
	0.18	E	_	15000
□MK105(0402)	0.2	С	20000	-
□MF105(0402)	0.3	Р	15000	-
	0.5	V	10000	_
□VK105(0402)	0.5	W	10000	-
MK107(0603)	0.45	К	4000	-
□WK107(0306) ※	0.5	V	-	4000
□MF107(0603)	0.8	А	4000	-
□VS107(0603)	0.7	С	4000	-
□MJ107(0603)	0.8	А	3000	3000
□MK212(0805)	0.45	К	4000	
□WK212(0508) ※	0.85	D	4000	_
□MF212(0805)	1.25	G	_	3000
□VS212(0805)	0.85	D	4000	_
	0.85	D	4000	_
□MJ212(0805)	1.25	G	-	2000
	0.85	D	4000	-
□MK316(1206)	1.15	F	_	3000
□MF316(1206)	1.6	L	-	2000
	1.15	F	-	3000
□MJ316(1206)	1.6	L	_	2000
	0.85	D		
	1.15	F		
□MK325(1210)	1.9	Ν	7 -	2000
□MF325(1210)	2.0max.	Y	1	
	2.5	М	_	1000
	1.9	Ν	—	2000
□MJ325(1210)	2.5	М	—	500(T), 1000(P)
□MK432(1812)	2.5	М	-	500

Note : 💥 LW Reverse type.

(2) Taping material



This catalog contains the typical specification only due to the limitation of space. When you consider the purchase of our products, please check our specification. For details of each product (characteristics graph, reliability information, precautions for use, and so on), see our Web site (http://www.ty-top.com/).

TAIYO YUDEN



3 Representative taping dimensions





Type(EIA)	Chip Cavity		Insertion Pitch	Insertion Pitch Tape Thic	
Type(EIA)	А	В	F	Т	T1
□MK063(0201)	0.37	0.67	2.0±0.05	0.45max.	0.42max.
□WK105(0204) ※					0.42max.
□MK105(0402) (*1 C)	0.65	1.15		0.4max.	0.3max.
□MK105(0402) (*1 P)				0.45max.	0.42max.
Note *1 Thickness, C:0.2mm ,P:0.3mm. ※ LW Reverse type.					Unit:mm



Type(EIA)	Chip (Cavity	Insertion Pitch	Tape Thickness
Type(EIA)	A	В	F	Т
□MK105 (0402) □MF105 (0402) □VK105 (0402)	0.65	1.15	2.0±0.05	0.8max.

Unit:mm





Type(EIA)	Chip (Cavity	Insertion Pitch	Tape Thickness	
Type(LIA)	А	В	F	Т	
□MK107(0603)					
□WK107(0306) 💥	1.0	1.8		1.1max.	
□MF107(0603)			40104		
MK212(0805)	1.05	0.4	4.0±0.1		
□WK212(0508) 💥	1.65	2.4		1.1max.	
DMK316(1206)	2.0	3.6			
Note:Taping size might	be different depending on	the size of the product.	※ LW Reverse type.	Unit : mm	

 0.9 ± 0.05

Note: Taping size might be different depending on the size of the product. % LW Reverse type.





Type(EIA)	Chip Cavity		Insertion Pitch	Tape Tł	nickness
Type(EIA)	А	В	F	К	Т
□MK021(008004)	0 1 2 5	0.27	1.0±0.02		
□VS021(008004)	0.135			0.5max.	0.25max.
□MK042(01005)	0.00	0.43			
□VS042(01005)	0.23				

Unit:mm(inch)

Unit:mm



Type(EIA)	Chip Cavity		Insertion Pitch	Tape Tł	nickness		
Type(EIA)	А	В	F	К	Т		
□MK105(0402)	0.6	1.1	2.0±0.1	0.6max	0.2±0.1		
□WK107(0306) ※	1.0	1.8		1.3max.	0.25 ± 0.1		
□MK212(0805)	1.65	165 0.4	2.4				
DMF212(0805)		2.4					
□MK316(1206)	2.0	3.6	4.0±0.1	3.4max.	0.6max.		
□MF316(1206)	2.0	5.0		5.4max.	0.0max.		
□MK325(1210)	2.8	3.6					
□MF325(1210)	2.0	5.0					

Note: 💥 LW Reverse type.

Unit:mm



Type(EIA)	Chip (Cavity	Insertion Pitch	Tape Tł	nickness
Type(EIA)	А	В	F	К	Т
□MK325(1210)	3.1	4.0	8.0±0.1	4.0max.	0.6max.
□MK432(1812)	3.7	4.9	8.0±0.1	4.0max.	0.6max.
					11.5

Unit : mm

④Trailer and Leader



⑤Reel size



А	В	С	D	E	R
ϕ 178±2.0	<i>ф</i> 50min.	ϕ 13.0±0.2	<i>ф</i> 21.0±0.8	2.0 ± 0.5	1.0
	Т	W			
4mm wide tape	1.5max.	5±1.0			
8mm wide tape	2.5max.	10±1.5	-		
12mm wide tape	2.5max.	14±1.5	Unit : mm		

6 Top Tape Strength

The top tape requires a peel-off force of 0.1 to 0.7N in the direction of the arrow as illustrated below.





Multilayer Ceramic Capacitors , Super Low Distortion Multilayer Ceramic Capacitors and High Reliability Application Multilayer Ceramic Capacitors are noted separately.

Medium-High Voltage Multilayer Ceramic Capacitor

RELIABILITY DATA

1. Operating Tempe	1. Operating Temperature Range					
	Temperature Compensating(Class1)	CG	: −55 to +125°C			
Specified Value	High Permittivity(Class2)	X7R, X7S X5R B SD	: $-55 \text{ to } +125^{\circ}\text{C}$: $-55 \text{ to } +85^{\circ}\text{C}$: $-25 \text{ to } +85^{\circ}\text{C}$: $-55 \text{ to } +125^{\circ}\text{C}$			

2. Storage Tempera	2. Storage Temperature Range					
	Temperature Compensating(Class1)	CG	: -55 to +125°C			
Specified Value	High Permittivity(Class2)		: −55 to +125°C : −55 to +85°C : −25 to +85°C : −55 to +125°C : −55 to +125°C			

3. Rated Voltage			
Specified Value	Temperature Compensating(Class1)	100VDC(HMK)	
Specified Value	High Permittivity (Class2)	100VDC(HMK), 250VDC(QMK), 630VDC(SMK)	

4. Withstanding Volt	age(Between terminals)	
Specified Value	No breakdown or damage	
Test Methods and Remarks	Applied voltage Duration Charge/discharge current	: Rated voltage × 2.5(HMK), Rated voltage × 2(QMK), Rated voltage × 1.2(SMK) : 1 to 5sec. : 50mA max.

5. Insulation Resista	ance		
Specified Value	Temperature Compensating	(Class1)	10000 MΩmin.
Specified Value	High Permittivity (Class2)		100M Ω • μ F or 10G Ω whichever is smaller.
Test Methods and Remarks	Applied voltage Duration Charge/discharge current	: Rated voltage(HMK, QMK), 500V(SMK) : 60±5sec. : 50mA max.	

6. Capacitance (Tolerance) $0.2pF \leq C \leq 5pF$: ±0.25pF Temperature Compensating(Class1) $0.2pF \leq C \leq 10pF$ $\pm 0.5 pF$ Specified Value $\pm 5\%$ or $\pm 10\%$ C>10pF : High Permittivity (Class2) $\pm 10\%$, $\pm 20\%$ Measuring frequency :1MHz±10% Temperature Compensating(Class1) Measuring voltage : 0.5~5Vrms Test Methods and **Bias application** : None Remarks :1kHz±10% Measuring frequency High Permittivity (Class2) Measuring voltage :1±0.2Vrms **Bias application** : None

7. Q or Dissipation	Factor				
Specified Value	Temperature Compensating(Class1)	$C < 30pF : Q \ge 400 + 20C$ $C \ge 30pF : Q \ge 1000$ (C:Nominal capacitance)			
	High Permittivity (Class2)	3.5%max(HMK),2.5%max(QMK, SMK)			
Test Methods and	Temperature Compensating(Class1)	Measuring frequency: 1MHz±10%Measuring voltage: 0.5~5VrmsBias application: None			
Remarks	High Permittivity(Class2)	Measuring frequency: 1kHz±10%Measuring voltage: 1±0.2VrmsBias application: None			



8. Temperature Cha	aracteristic of Capacitanc	e		
	Temperature Compensa	iting(Class1)	CG :0±30	0ppm/°C(−55 to +125°C)
Specified Value	High Permittivity(Clas	s2)	X5R : ±15 X7R : ±15 X7S : ±22	$\%(-25 \text{ to } +85^{\circ}\text{C})$ $\%(-55 \text{ to } +85^{\circ}\text{C})$ $\%(-55 \text{ to } +125^{\circ}\text{C})$ $\%(-55 \text{ to } +125^{\circ}\text{C})$ $(-55 \text{ to } +125^{\circ}\text{C})$
Test Methods and Remarks	following equation. Step CG, 1 Min 2 20°C	B、X5R、3 imum operating temper imum operating temper (%) in Step 1 or Step 3	X7R、X7S、SD rature 25°C	quilibrium, and the temperature characteristic shall be calculated from the

9. Deflection		
Specified Value	Temperature Compensating(Class1)	Appearance: No abnormalityCapacitance change: Within $\pm 5\%$ or ± 0.5 pF, whichever is larger.
	High Permittivity(Class2)	Appearance: No abnormalityCapacitance change: Within±10%
Test Methods and Remarks	Warp : 1mm Duration : 10sec. Test board : Glass epoxy-resin substrate Thickness : 1.6mm Capacitance measurement shall be conducted	$\begin{array}{c} Warp \\ \hline \\ 45\pm2 \\ \hline \\ 45\pm2 \\ \hline \\ \end{array} \end{array}$ (Unit: mm)

10. Adhesive Streng	th of Terminal Electrodes	
Specified Value	Temperature Compensating(Class1)	No terminal separation or its indication.
Specified value	High Permittivity (Class2)	
Test Methods and Remarks	Applied force : 5N Duration : 30±5sec.	Hooked jig Board Hooked jig Board Chip

11. Solderability							
Specified Value	Temperature Compensating(Class1)	At least 05% of				
Specified value	High Permittivity(Class2)		At least 95% of terminal electrode is covered by new solder				
		Eutecti	c solder	Lead-free solder			
Test Methods and	Solder type	H60A o	or H63A	Sn-3.0Ag-0.5Cu			
Remarks	Solder temperature	230	±5℃	245±3°C			
	Duration		4±1	sec.]		



12. Resistance to S	oldering				
Specified Value	Temperature Compensating(Class1)		Appearance Capacitance change Q Insulation resistance Withstanding voltage	: Initial va : Initial va	$\pm 2.5\%$ or ± 0.25 pF, whichever is larger.(HMK) lue
Specified value	High Permittivity(Class2	2)	Appearance Capacitance change Dissipation facto Insulation resistance Withstanding voltage	: Initial va : Initial va	15%(HMK), ±10%(QMK, SMK) alue
		Temperature Compensating(Class1)			
	Preconditioning	None			
	Solder temperature	270±5℃			
	Duration	3±0.5sec.			
	Preheating conditions	80 to 100°C, 2 to 5 min. 150 to 200°C, 2 to 5min.			
Test Methods and	Recovery	24 \pm 2hrs under the standard condition Note3			
Remarks					
Remarks		High Permittivity (Class2)			
	Preconditioning	Thermal treatment	(at 150°C for 1hr) Note1		
	Solder temperature	270±5°C			
	Duration	3±0.5sec.			
	Preheating conditions	80 to 100°C, 2 to 5	min.		
	Preneating conditions	150 to 200°C, 2 to	5min.		
	Recovery	24±2hrs under the	e standard condition Note3	}	

13. Temperature Cy	cle(Thermal Shock)						
Specified Value	Temperature Compensating(Class1)			: V : I : I	No abnormality Vithin ±2.5% or ± nitial value nitial value petween terminals)	•	
Specified Value	High Permittivity(Cla	Appearance Capacitance change Dissipation facto Insulation resistance Withstanding voltage	: \ : I : I	: No abnormality : Within±15%(HMK), ±10%(QMK, SMK) : Initial value : Initial value (between terminals) : No abnormality			
			Class 1	lass 1			
	Preconditioning	None			Thermal treatme	nt (at 150°C fo	or 1 hr) Note 1
		Step Temperatu		ature(°C)	Time(min.)	
Test Methods and		1	Minimum opera	ating te	g temperature 30±3		
Remarks	1 cycle	2	Normal t	empera	ature	2 to 3	
Remarks		3	Maximum opera	iting t	emperature	30±3	
		4	Normal t	Normal temperature			
	Number of cycles			5 tim	ies		<u>.</u>
	Recovery	6 to 24 hrs(Sta	andard condition)Note 3		24±2 hrs(Standard conditi	on) Note 3

14. Humidity(Stea	dy state)				
Specified Value	Temperature Compensating(Class1) High Permittivity (Class2)		Appearance Capacitance chang Q Insulation resistance	$\begin{array}{l} : C < 10 pF : Q \ge 200 + 10C \\ 10 \le C < 30 pF : Q \ge 275 + 2.5C \\ C \ge 30 pF : Q \ge 350 (C : Nominal capacitance) \end{array}$	
			Appearance Capacitance chang Dissipation factor Insulation resistance		
		Class	1	Class 2	
	Preconditioning	None		Thermal treatment(at 150°C for 1 hr) Note 1	
Test Methods and	Temperature	40±2°	C	40±2°C	
Remarks	Humidity	90 to 95%	6RH	90 to 95%RH	
	Duration	500+24/-	-0 hrs	500+24/-0 hrs	
	Recovery	6 to 24 hrs(Standard o	condition)Note 3	24±2 hrs(Standard condition)Note 3	



15. Humidity Loadin	g			
Specified Value	Temperature Comper	usating(Class1)	Appearance Capacitance change Q Insulation resistance	: No abnormality : Within $\pm 7.5\%$ or ± 0.75 pF, whichever is larger (HMK). : C < 30 pF:Q $\ge 100 + 10$ C/3 C ≥ 30 pF:Q ≥ 200 (C:Nominal capacitance) : 500 M Ω min.
	High Permittivity(Cl	ass2)	Appearance Capacitance change Dissipation factor Insulation resistance	: No abnormality : Within±15% : 7%max(HMK), 5%max(QMK, SMK). : 10M Ω/F or 500M Ω whichever is smaller.
	According to JIS 510	1-1.		
		Cla	ass 1	Class 2
	Preconditioning	None		Voltage treatment (Rated voltage are applied for 1 hour at 40°C) Note 2
	Temperature	40±2°C		40±2°C
Test Methods and Remarks	Humidity	90 to 95%RH		90 to 95%RH
Remarks	Duration	500+24	4∕—0 hrs	500+24/-0 hrs
	Applied voltage	Rated	voltage	Rated voltage
	Charge/discharge current	50m/	A max.	50mA max.
	Recovery	6 to 24 hrs(Standa	ard condition)Note 3	24±2 hrs(Standard condition) Note 3

			Appearance		: No abnormality		
			Capacitance cha	ange	: Within $\pm 7.5\%$ or ± 0.75 pF, whichever is larger.(HMK)		
	Temperature Comper	nsating(Class1)	Q		: C<30pF:Q≧100+10C/3		
					C≧30pF∶Q≧200 (C∶Nominal capacitance)		
Specified Value			Insulation resist	ance	: 500 M Ω min.		
			Appearance		: No abnormality		
	High Permittivity (Cl	acc2)	Capacitance cha	ange	: Within±15%		
	Thigh Fernittivity (O	assz/	Dissipation facto	or	: 7%max(HMK), 5%max(QMK, SMK).		
			Insulation resist	ance	: 50M $\Omega\mu$ F or 1000M Ω whichever is smaller.		
	According to JIS 510	1-1.					
		Class 1			Class 2		
	Preconditioning	None			Voltage treatment Note 2		
	Temperature	Maximum operating temperature			Maximum operating temperature		
Test Methods and	Duration	1000 + 48 / -0 hrs			1000+48/-0 hrs		
Remarks	Applied voltage	Rated voltage × 2(HMK)			Rated voltage × 2(HMK), Rated voltage × 1.5 (QMK),		
	Applied Voltage				Rated voltage × 1.2(SMK)		
	Charge/discharge current	50mA m	ax.		50mA max.		
	Recovery	6 to 24hr(Standard c	ondition) Note 3		24 \pm 2 hrs(Standard condition)Note 3		
Note1 Thermal trea	tment : Initial value sha	II be measured after tes	t sample is heat-tr	eated a	at $150 + 0/-10^{\circ}$ C for an hour and kept at room tempera		
	for 24 ± 2 hours	i.					
Note2 Voltage treat	ment : Initial value sha	I be measured after test	sample is voltage-	treated	d for an hour at both the temperature and voltage specified in		
	test conditions	, and kept at room temp	erature for $24\pm2h$	ours.			
	distant Tanan and America	i to 35°C, Relative humic		A :			

When there are questions concerning measurement results, in order to provide correlation data, the test shall be conducted under the following condition.

Temperature: 20 \pm 2°C, Relative humidity: 60 to 70 % RH, Air pressure: 86 to 106kPa

Unless otherwise specified, all the tests are conducted under the "standard condition".



Precautions on the use of Multilayer Ceramic Capacitors

PRECAUTIONS

	♦Verification of operating environment, electrical rating and performance
	1. A malfunction of equipment in fields such as medical, aerospace, nuclear control, etc. may cause serious harm to human life or have severe social ramifications.
	Therefore, any capacitors to be used in such equipment may require higher safety and reliability, and shall be clearly differentiated from
	them used in general purpose applications.
Precautions	♦ Operating Voltage (Verification of Rated voltage)
	1. The operating voltage for capacitors must always be their rated voltage or less.
	If an AC voltage is loaded on a DC voltage, the sum of the two peak voltages shall be the rated voltage or less.
	For a circuit where an AC or a pulse voltage may be used, the sum of their peak voltages shall also be the rated voltage or less.
	2. Even if an applied voltage is the rated voltage or less reliability of capacitors may be deteriorated in case that either a high frequency AC
	voltage or a pulse voltage having rapid rise time is used in a circuit.

. PCB Design	1										
	♦Pattern	config	gurations (Des	sign of Land-p	atterns)						
	1. When capacitors are mounted on PCBs, the amount of solder used (size of fillet) can directly affect the capacitor performance										
	The	refore,	the following	items must be	carefully con	sidered in the	design of lan	d patterns:			
	(1)	Excess	sive solder ap	olied can cau	se mechanica	I stresses wh	nich lead to o	chip breaking	or cracking.	Therefore, pl	ease consid
			opriate land-p	-	-						
Precautions	(2) When more than one component are jointly soldered onto the same land, each component's soldering point shall be separated by										
	solder−resist. ♦Pattern configurations(Capacitor layout on PCBs)										
		-		-						с. · ·	(ר
	After capacitors are mounted on boards, they can be subjected to mechanical stresses in subsequent manufacturing processes (PC										
	cutting, board inspection, mounting of additional parts, assembly into the chassis, wave soldering of the boards, etc.). For this reason, lar pattern configurations and positions of capacitors shall be carefully considered to minimize stresses.										
		-				be callerally c		11111120 30 0	3363.		
			gurations (Des	• ·		-f	مامط امسط سمغة				-
			diagrams and t				ded land patt	erns to preve	nt excessive s	solder amount	s.
			ended land dim r Ceramic Cap	-					Land pattern	e for PCBe	
		: mm)							-	and pattern	
			Idering						Chip capacito		lder-resist
		уре	107 212 316 325								
		L	1.6	2.0	3.2	3.2					
	Size	W	0.8	1.25	1.6	2.5					
		A	0.8 to 1.0	1.0 to 1.4	1.8 to 2.5	1.8 to 2.5					
		В	0.5 to 0.8	0.8 to 1.5	0.8 to 1.7	0.8 to 1.7		1	B A	B	
		С	0.6 to 0.8	0.9 to 1.2	1.2 to 1.6	1.8 to 2.5					
									Chip capacit	or	
							w				
									<u>ــــــ</u>	→	
Technical											
considerations	Reflow-s			040	060	105	107	010	216	205	400
	I y	/pe L	021 0.25	042	063	105 1.0	107	212 2.0	316 3.2	325 3.2	432 4.5
	Size	W	0.25	0.4	0.0	0.5	0.8	1.25	1.6	2.5	3.2
		4 VV	0.095~0.135		0.3	0.5	0.8~1.0	0.8~1.2	1.8~2.5	1.8~2.5	2.5~3.5
		B	0.035~0.135		0.20~0.30	0.40~0.50	0.6~0.8	0.8~1.2	1.0~1.5	1.0~1.5	1.5~1.8
		C			0.25~0.40	0.45~0.55	0.6~0.8	0.9~1.6	1.2~2.0	1.8~3.2	2.3~3.5
	C 0.110~0.150 0.15~0.30 0.25~0.40 0.45~0.55 0.6~0.8 0.9~1.6 1.2~2.0 1.8~3.2 2.3~3.5 Note : Recommended land size might be different according to the allowance of the size of the product. 1.8~3.2 2.3~3.5										
	UWDC: Recommended land dimensions for reflow-soldering										
	LWDC: Recommended land dimensions for reflow-soldering (unit: mm)										
	T	ype	105	107	212						
		L	0.52	0.8	1.25					w	
	Size	W	1.0	1.6	2.0						
		A	0.18~0.22	0.25~0.3	0.5~0.7						
	В		0.2~0.25	0.3~0.4	0.4~0.5					<u> </u>	
	C		0.9~1.1	1.5~1.7	1.9~2.1				L		
									•		

TAIYO YUDEN



3. Mounting	
Precautions	 Adjustment of mounting machine When capacitors are mounted on PCB, excessive impact load shall not be imposed on them. Maintenance and inspection of mounting machines shall be conducted periodically. Selection of Adhesives When chips are attached on PCBs with adhesives prior to soldering, it may cause capacitor characteristics degradation unless the following factors are appropriately checked : size of land patterns, type of adhesive, amount applied, hardening temperature and hardening period. Therefore, please contact us for further information.





4. Soldering						
Precautions	 Selection of Flux Since flux may have a significant effect on the performance of capacitors, it is necessary to verify the following conditions prior to use; (1) Flux used shall be less than or equal to 0.1 wt%(in Cl equivalent) of halogenated content. Flux having a strong acidity content shall not be applied. (2) When shall capacitors are soldered on boards, the amount of flux applied shall be controlled at the optimum level. (3) When water-soluble flux is used, special care shall be taken to properly clean the boards. Soldering Temperature, time, amount of solder, etc. shall be set in accordance with their recommended conditions. Sn-Zn solder paste can adversely affect MLCC reliability. Please contact us prior to usage of Sn-Zn solder. 					
Technical considerations	 Selection of Flux 1-1. When too much halogenated substance (Chlorine, etc.) content is used to activate flux, or highly acidic flux is used, it may lead to corrosion of terminal electrodes or degradation of insulation resistance on the surfaces of the capacitors. 1-2. Flux is used to increase solderability in wave soldering. However if too much flux is applied, a large amount of flux gas may be emitted and may adversely affect the solderability. To minimize the amount of flux applied, it is recommended to use a flux-bubbling system. 1-3. Since the residue of water-soluble flux is easily dissolved in moisture in the air, the residues on the surfaces of capacitors in high humidity conditions may cause a degradation of insulation resistance and reliability of the capacitors. Therefore, the cleaning methods and the capability of the machines used shall also be considered carefully when water-soluble flux is used. 					



Soldering

- · Ceramic chip capacitors are susceptible to thermal shock when exposed to rapid or concentrated heating or rapid cooling.
- Therefore, the soldering must be conducted with great care so as to prevent malfunction of the components due to excessive thermal shock.
- Preheating : Capacitors shall be preheated sufficiently, and the temperature difference between the capacitors and solder shall be within 130°C.
- · Cooling : The temperature difference between the capacitors and cleaning process shall not be greater than 100°C.







②Because excessive dwell times can adversely affect solderability, soldering duration shall be kept as close to recommended times as possible. soldering for 2 times.





Caution

Wave soldering must not be applied to capacitors designated as for reflow soldering only. soldering for 1 times.



5. Cleaning	
Precautions	 Cleaning conditions 1. When PCBs are cleaned after capacitors mounting, please select the appropriate cleaning solution in accordance with the intended use of the cleaning. (e.g. to remove soldering flux or other materials from the production process.) 2. Cleaning condition shall be determined after it is verified by using actual cleaning machine that the cleaning process does not affect capacitor's characteristics.
Technical considerations	 The use of inappropriate cleaning solutions can cause foreign substances such as flux residue to adhere to capacitors or deteriorate their outer coating, resulting in a degradation of the capacitor's electrical properties (especially insulation resistance). Inappropriate cleaning conditions (insufficient or excessive cleaning) may adversely affect the performance of the capacitors. In the case of ultrasonic cleaning, too much power output can cause excessive vibration of PCBs which may lead to the cracking of capacitors or the soldered portion, or decrease the terminal electrodes' strength. Therefore, the following conditions shall be carefully checked; Ultrasonic output : 20 W/2 or les Ultrasonic frequency : 40 kHz or less Ultrasonic washing period : 5 min. or less

6. Resin coating	and mold
Precautions	 With some type of resins, decomposition gas or chemical reaction vapor may remain inside the resin during the hardening period or while left under normal storage conditions resulting in the deterioration of the capacitor's performance. When a resin's hardening temperature is higher than capacitor's operating temperature, the stresses generated by the excessive heat may lead to damage or destruction of capacitors. The use of such resins, molding materials etc. is not recommended.

7. Handling	
Precautions	 Splitting of PCB When PCBs are split after components mounting, care shall be taken so as not to give any stresses of deflection or twisting to the board. Board separation shall not be done manually, but by using the appropriate devices. Mechanical considerations Be careful not to subject capacitors to excessive mechanical shocks. If ceramic capacitors are dropped onto a floor or a hard surface, they shall not be used. Please be careful that the mounted components do not come in contact with or bump against other boards or components.

	♦Storage			
Precautions	 To maintain the solderability of terminal electrodes and to keep packaging materials in good condition, care must be taken to control temperature and humidity in the storage area. Humidity should especially be kept as low as possible. Recommended conditions Ambient temperature : Below 30°C Humidity : Below 70% RH The ambient temperature must be kept below 40°C. Even under ideal storage conditions, solderability of capacitor is deteriorated as time passes, so capacitors shall be used within 6 months from the time of delivery. Ceramic chip capacitors shall be kept where no chlorine or sulfur exists in the air. The capacitance values of high dielectric constant capacitors will gradually decrease with the passage of time, so care shall be taken to design circuits. Even if capacitance value decreases as time passes, it will get back to the initial value by a heat treatment at 150°C for 1hour. 			
Technical onsiderations	If capacitors are stored in a high temperature and humidity environment, it might rapidly cause poor solderability due to terminal oxidation and quality loss of taping/packaging materials. For this reason, capacitors shall be used within 6 months from the time of delivery. If exceeding the above period, please check solderability before using the capacitors.			

